Notice of References Cited

Application/Control No 09/783,287	Applicant(s)/Pater Reexamination OHMI ET AL.			
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Basia Ridley	1764	Page 1 of 1		

U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04054184 A	02-1992	Japan	WATANABE et al.	/
	0	JP 06122580 A	05-1994	Japan	OGURA et al.	/
	Р	JP 52111891 A	09-1977	Japan		/
	Q					
	R					
	S					
	Τ					

NON-PATENT DOCUMENTS

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